

Innovation for the next generation

# ML4015F

## Optical and Electrical Sampling Oscilloscope



Ideal for  $\geq$  53.125 GBaud PAM4 and NRZ transceiver testing | Supports 802.3 measurements, SSPRQ patterns | Open Eye MSA support | Up to 112G/Lane SM/MM and electrical channel

### Summary

The Data Center Interconnect market is rapidly transitioning to 50G Ethernet and 32GT/64GT PCIe, as well as 112G per channel for both optical and electrical interfaces. Cost-effective characterization tools are required to enable this technology transition and to accelerate the deployment of Data Center Interconnects, such as optical transceivers and passive cable interconnect.

The characterization of these transceivers introduces a myriad of test and measurement challenges. Besides the 53.125 GBaud PAM4 optical transmitter market, well served by many - typically quite expensive- instruments, there is a strong need for slightly slower standards' measurements. MultiLane introduces the ML4015F Optical and Electrical Sampling Oscilloscopes as a well-correlated alternative to incumbent solutions at an excellent-value price point.

# ML4015F

## Optical and Electrical DSO

### Introduction

The ML4015F is a fully featured, cost effective single channel sampling oscilloscope. It can be configured to have an optical roll-off of either 33 or 42 GHz. The supported wavelengths range from 1260 to 1650 nm single mode or 700 to 870 nm multimode. The ML4015F can also be configured with a 67 GHz differential electrical sampler.

### Key Features

The ML4015F family of optical DSOs boasts an extensive set of features and functions that are unique in the industry. These include:

- A noise floor of 10  $\mu$ W resp. 12-14  $\mu$ W (33 vs 42 GHz roll-off)
- Sensitivity level of -10 dBm for a 53.125 Gbps NRZ signal 1310 nm
- Up to 50 - 70 MHz sampling rate
- Less than 10 seconds TDECQ on an SSPRQ pattern
- FPGA-based architecture enabling TDECQ measurements via capture of SSPRQ and PRBS16 patterns
- An extensive library of built-in DSP filters such as Bessel-Thomson, CTLE, DFE, FFE, de-embedding, and component emulation, all available free of charge in the standard GUI
- Comprehensive eye mask library
- Individual impulse response calibration performed at factory
- Compact instrument footprint with a ruggedized enclosure and handle
- Comprehensive set of APIs and associated sample scripts to accelerate automation development under Linux and Windows, supporting Python, LabView, MATLAB, and C#

### Typical Optical Applications

- Production/manufacturing testing of electrical and optical transceivers
- Benchtop characterization of optical circuits
- Qualification of PAM-N and NRZ optical modulators and drivers
- Sensitivity testing of optical receivers
- System testing with a clock recovery

### Typical Electrical Applications

- TP1a stress calibration
- SERDES characterization
- Receiver electrical output characterization
- Benchtop characterization of electrical circuits

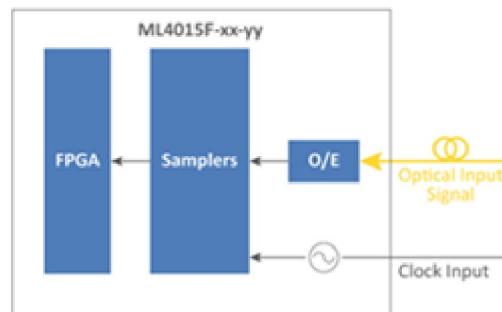


Figure 1: Schematics of the ML4015F-2X-OPT

## Optical Specifications

Parameters	Specifications
<b>SM Wavelength</b>	1260 - 1650 nm
<b>MM Wavelength</b>	700 - 870 nm
<b>Calibrated Wavelengths</b>	1310 and 850 nm
<b>Optical Bandwidth</b>	42 GHz Single Mode
	33 GHz Broadband
<b>Noise RMS at 1310 nm</b>	10 $\mu$ W at 33 GHz 12-14 $\mu$ W at 42 GHz
<b>Sensitivity at 1310 nm at 53.125 Gbit/s</b>	< -10 dBm
<b>Sensitivity at 850 nm at 53.125 Gbit/s</b>	< -9 dBm
<b>Intrinsic Jitter</b>	400 fs rms
<b>Input Power Damage Level</b>	10 dBm
<b>Fiber Input SM</b>	9 / 125 $\mu$ m
<b>Fiber Input MM</b>	50 / 125 $\mu$ m
<b>Connector</b>	FC-UPC
<b>Analog Sampling Hardware Resolution</b>	14 bits
<b>Clock Input Bandwidth</b>	0.1 - 20 GHz
<b>Clock Input Swing</b>	225-1800 mVpp
<b>Clock Input Connector</b>	Key 2.92 mm (f), 50 $\Omega$
<b>Pattern Capture</b>	> 8 M Samples
<b>Sampling Frequency</b>	50 - 70 MHz
<b>Memory</b>	8 MSa
<b>Pattern Lock</b>	Up to PRBS16, SSPRQ
<b>Temperature Range</b>	0 - 75 °C
<b>Room Temperature Range</b>	0 - 30 °C
<b>Line Power</b>	100 - 240 V AC, 50 / 60 Hz

## Electrical Specifications

Parameters	Specifications
<b>Electrical Amplitude</b>	< 600 mV SE and < 1200 mV Diff
<b>Electrical Bandwidth</b>	67 GHz
<b>Intrinsic Jitter</b>	350 fs rms
<b>Electrical Channel Connectors</b>	Key 1.85mm Female.
<b>Analog Sampling Hardware Resolution</b>	14 bits
<b>Clock Input Bandwidth</b>	0.1 - 20 GHz
<b>Clock Input Swing</b>	225 - 1800 mVpp
<b>Clock Input Connector</b>	Key 2.92 mm (f), 50 $\Omega$
<b>Pattern Capture</b>	> 8 M Samples
<b>Sampling Frequency</b>	50 - 70 MHz
<b>Memory</b>	8 MSa
<b>Pattern Lock</b>	Up to PRBS16, SSPRQ
<b>Temperature Range</b>	0 - 75 °C
<b>Room Temperature Range</b>	0 - 30 °C
<b>Line Power</b>	100 - 240 V AC, 50 / 60 Hz

## Recommended PC Specifications

<b>OS</b>	Windows 11 64-bit
<b>Processor</b>	Core i7 / Ryzen 7
<b>Memory</b>	32 GB
<b>GPU</b>	4 GB (Dedicated)
<b>Storage</b>	10 GB (Dedicated)

## Minimum PC Specifications

<b>OS</b>	Windows 10 64-bit
<b>Processor</b>	Core i5 / Ryzen 5
<b>Memory</b>	16 GB
<b>GPU</b>	2 GB (Dedicated)
<b>Storage</b>	5 GB (Dedicated)

## Supported DSP Functions

- Frequency response correction of O/E & analog front end
- N<sup>th</sup>-Order Bessel-Thomson
- CTLE adaptive or manual
- FFE adaptive or manual
- DFE adaptive or manual
- De-embedding or embedding of four-ports (.s4p) and two-ports (.s2p) files
- Moving average

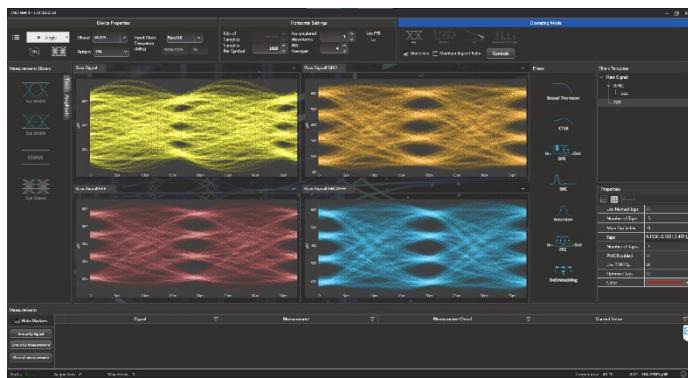


Figure 2: Multi-Signal Display Feature

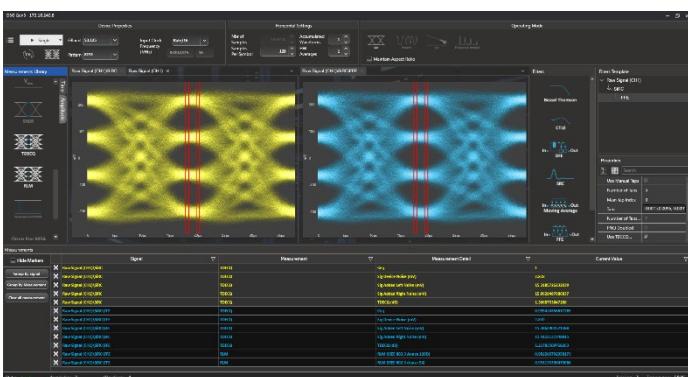


Figure 3: 53.125 Gbaud Electrical Eye Diagram

## Supported Measurements

Coding	Measurements
PAM4	TDECQ
	SNDR
	Open Eye MSA
	RLM
	OMA <sub>outer</sub>
	Eye Height by BER
	Eye Width by BER
	Top & Base
	Min & Max
	One & Zero
NRZ	Transition Time
	Crossing %
	AOP
	OMA
	Mask
	Peak to Peak
	Eye Amplitude
	Eye Height
	Eye Width
	Jitter
	SNR
	ER
	VEC
	Vrms
	RJ
	Noise

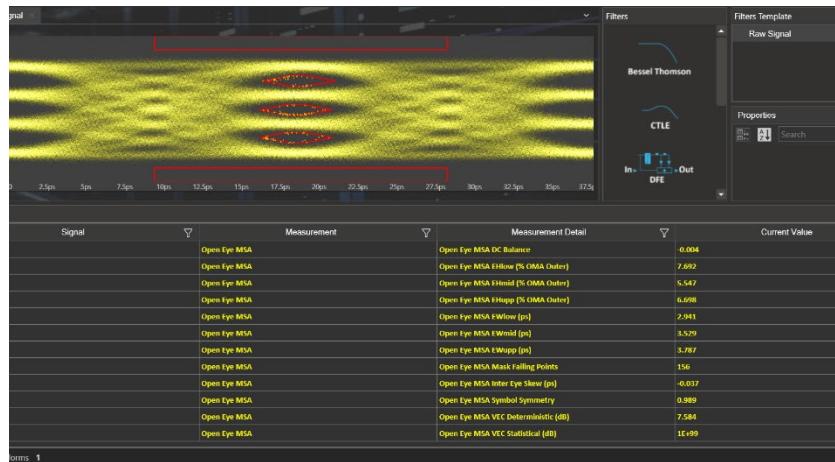


Figure 4: Supported Open Eye MSA Measurements

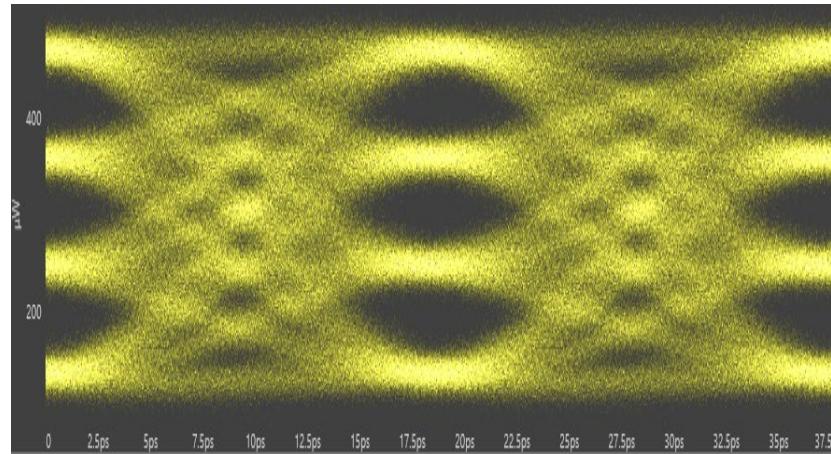


Figure 5: 53.125 GBaud – PNQ9 Doubled – Optical Eye Diagram – SRC+FFE

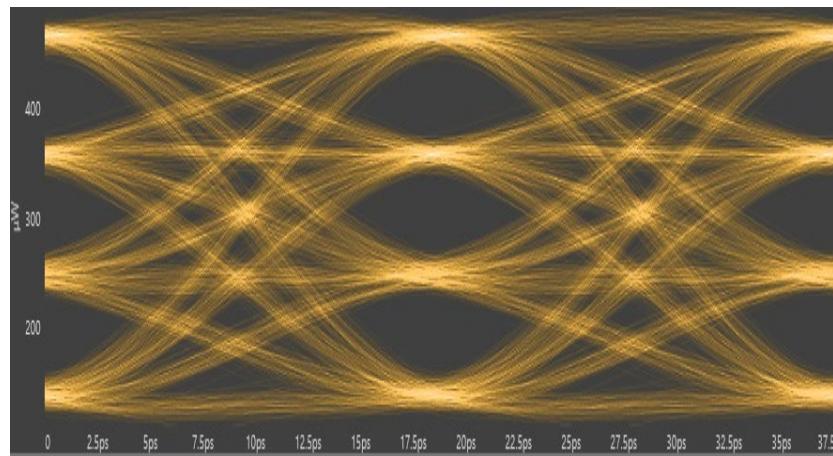


Figure 6: 53.125 GBaud Optical Eye Diagram – Bessel Thomson + FFE

## Triggering ML4015F Using Optical Clock Recovery Module

An optical clock recovery can be used. The recovered clock triggers the ML4015F Optical Scope to perform NRZ or PAM4 optical measurements such as TDECQ, OMA, and ER.

### Test Setup Using ML4015F

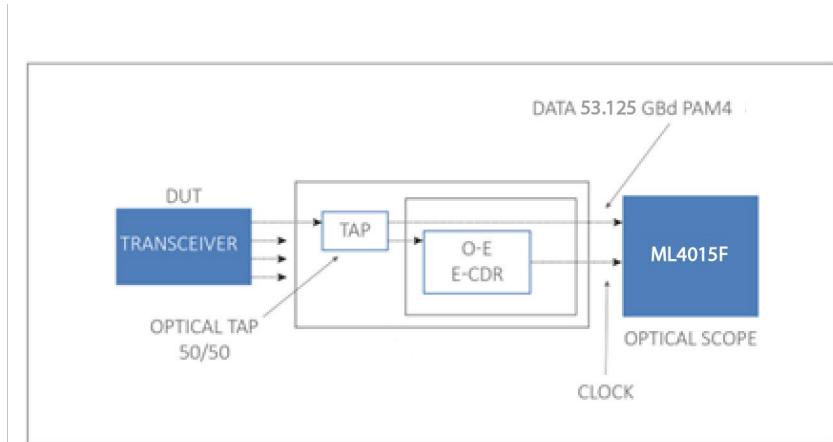


Figure 7: Functional Block Diagram of the ML4015F

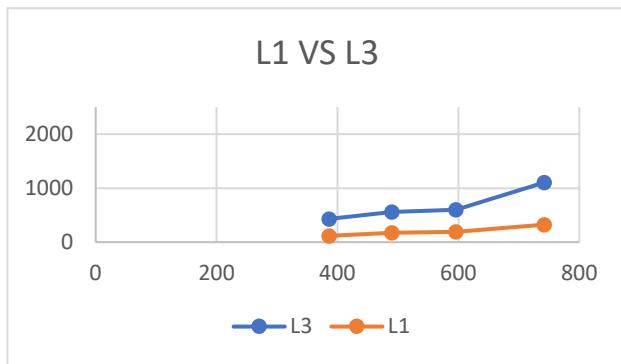


Figure 8: L1 and L3 Comparison

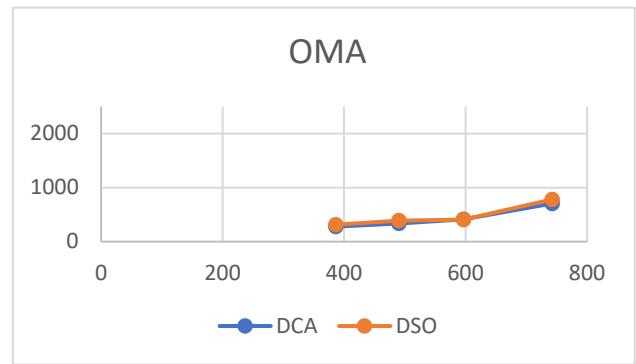


Figure 9: OMA-DCAM and OMA-DSO Comparison

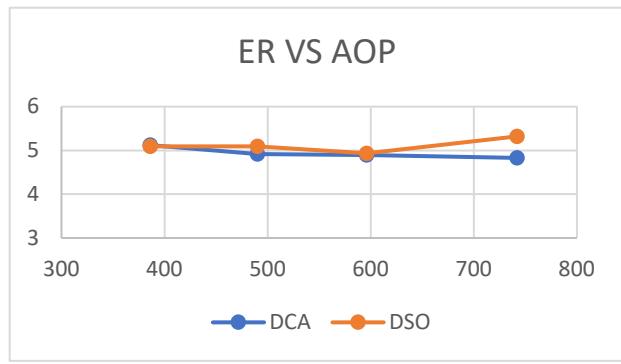


Figure 10: ER-DCAM and ER-DSO Comparison

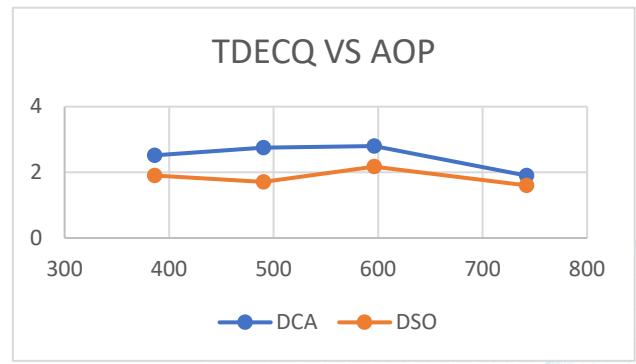


Figure 11: TDECQ-DCAM and TDECQ-DSO Comparison

## Mechanical Dimensions

The ML4015F is a benchtop instrument that also fits in a 19-inch 2U rack. It has a ruggedized Enigma enclosure with improved mechanical rigidity. Two ML4015Fs arranged side by side comprise one 2U slot in the rack. MultiLane also supplies the needed bracket.



Figure 12: ML4015F Mechanical Dimensions

## Ordering Information

ML Part Number	Description
ML4015F-2x-70-OPT-SM42	One Diff Electrical 67 GHz and 1 Optical Single Mode 42 GHz Receiver
ML4015F-2x-70-OPT-33	One Diff Electrical 67 GHz and 1 Optical Broadband 33 GHz Receiver

## Recommended Accessories

Instruments	Recommended Cables	Comments
ML4015F-2x-70-OPT-SM42	1x MLCBPS-2.92-30/60	2.92 mm connector, Clock Input Cable, 30 or 60 cm
	2x MLCBPS-1.85-30/60	1.85 mm connector, 2 Data in Cables, 30 or 60 cm
ML4015F-2x-70-OPT-33	1x MLCBPS-2.92-30/60	2.92 mm connector, Clock Input Cable, 30 or 60 cm
	2x MLCBPS-1.85-30/60	1.85 mm connector, 2 Data in Cables, 30 or 60 cm

Please contact us at [sales@multilaneinc.com](mailto:sales@multilaneinc.com)

This equipment contains ESD sensitive components and may become damaged when contacted with an electrostatic charge. To prevent equipment damage, please use proper grounding techniques.

